



Approved Method: **Electrical and Photometric  
Measurements of  
Single-Based  
Fluorescent Lamps**

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**IES Approved Method  
for the  
Electrical and Photometric Measurements of  
Single-Based Fluorescent Lamps**

Prepared by the Subcommittee on  
The Subcommittee on Photometry of Light Sources  
of the IES Testing Procedures Committee

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## Contents

Foreword .....	1
Introduction .....	1
1.0 Scope .....	2
2.0 Normative References .....	2
3.0 Definitions .....	2
3.1 Amalgam .....	2
3.2 Cold Chamber or Cold Spot .....	2
4.0 Ambient and Physical Conditions .....	2
4.1 General .....	2
4.2 Vibration .....	3
4.3 Temperature .....	3
4.4 Air Movement .....	3
4.5 Operating Orientation .....	3
5.0 Power Source Characteristics .....	3
5.1 Power Supply Requirements .....	3
5.1.1 Voltage Waveshape .....	3
5.1.2 Voltage Regulation .....	3
5.1.3 Power Supply Impedance .....	3
5.2 Auxiliary equipment .....	3
5.2.1 Reference Circuit Requirements .....	3
5.2.2 Circuits for High Frequency Operation of lamps with electrodes .....	4
5.2.2.1 Preheat Start Lamps, Non-Integrated, Line Frequency .....	4
5.2.2.2 Rapid Start Lamps, Non-Integrated, Line Frequency .....	4
5.2.2.3 Instant Start Lamps, Non-Integrated, Line frequency .....	5
5.2.3 Integrated Compact Fluorescent Lamp and Integrated Electrodeless Fluorescent Lamps .....	6
5.2.4 Starters .....	6
5.3 Electrical Instrumentation .....	6
5.3.1 Frequency Response .....	6
5.3.2 Impedance Limitations .....	7
5.3.3 Instrument Tolerance/Uncertainty .....	7
6.0 Testing Procedures Requirements .....	7
6.1 Preparation for Test .....	7
6.1.1 Marking and Handling Requirements .....	7
6.1.2 Seasoning .....	7
6.1.3 Preburn .....	7
6.1.4 Transfer of Lamp to the Measurement Circuit .....	7

6.2	Stabilization	7
6.2.1	Preferred Method	7
6.2.2	Unusual Conditions	7
6.3	Photometric Measurement Requirements	8
6.3.1	Integrating Sphere Measurement	8
6.3.2	Intensity (Candela) Distribution	8
6.4	Color Measurements	8
7.0	Test Report	8
	Informative References	9
	Annex A - Photometric measurements of lamps using fixed current method at high frequency	9
	Annex B - Use of the "Peak" Method	10
	Annex C - Normal Intensity (Candela) Measurements	10

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